

# **MOSFET** - N-Channel QFET

1000 V, 8 A, 1.45  $\Omega$ 

# **FQD30N06**

### Description

This N-Channel Enhancement Mode Power MOSFET is produced using **onsemi**'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

#### **Features**

- 22.7 A, 60 V  $R_{DS(on)} = 45 \text{ m}\Omega \text{ (Max.)}$  @  $V_{GS} = 10 \text{ V}$ ,  $I_D = 11.4 \text{ A}$
- Low Gate Charge (Typ. 19 nC)
- Low Crss (Typ. 40 pF)
- 100% Avalanche Tested
- This Device is Pb-Free Halide, Free and RoHS Compliant

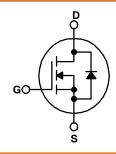
# MOSFET MAXIMUM RATINGS (T<sub>C</sub> = 25°C unless otherwise noted.)

Symbol	Parameter	Value	Unit
V <sub>DSS</sub>	Drain to Source Voltage	60	V
Ι <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C) - Continuous (T <sub>C</sub> = 100°C)	22.7 14.3	Α
I <sub>DM</sub>	Drain Current – Pulsed (Note 1)	90.8	Α
$V_{GSS}$	Gate-Source Voltage	±25	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 2)	280	mJ
I <sub>AR</sub>	Avalanche Current (Note 1)	22.7	Α
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)	4.4	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	7.0	V/ns
P <sub>D</sub>	Power Dissipation (T <sub>A</sub> = 25°C) *	2.5	W
	Power Dissipation - (T <sub>C</sub> = 25°C) - Derate Above 25°C	44 0.35	W W/°C
T <sub>J</sub> ,T <sub>STG</sub>	T <sub>J</sub> ,T <sub>STG</sub> Operating and Storage Temperature Range		°C
TL	T <sub>L</sub> Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



TO-252-3 CASE 369AS



#### **MARKING DIAGRAM**

&Z&3&K FQD 30N06

&Z = Assembly Plant Code &3 = Numeric Date Code &K = 2-Digit Lot Code FQD30N06 = Specific Device Code

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
FQD30N06	TO-252-3 (Pb-Free)	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case, Max.	2.85	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Minimum Pad of 2–oz Copper), Max.	110	°C/W
	Thermal Resistance, Junction to Ambient (*1 in² Pad of 2-oz Copper), Max.	50	

# **ELECTRICAL CHARACTERISTICS** $(T_C = 25^{\circ}C \text{ unless otherwise noted})$

Symbol	Parameter Parameter	Test Conditions	Min	Тур	Max	Unit
Off Chara	cteristics			,,,	ı	ı
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	60	-	_	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C	-	0.06	-	V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V	-	-	1	μΑ
	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 48 V, T <sub>C</sub> = 125°C	_	_	10	μΑ
I <sub>GSSF</sub>	Gate to Body Leakage Current, Forward	V <sub>GS</sub> = 25 V, V <sub>DS</sub> = 0 V	-	-	100	nA
I <sub>GSSR</sub>	Gate to Body Leakage Current, Reverse	V <sub>GS</sub> = -25 V, V <sub>DS</sub> = 0 V	-	-	-100	nA
On Chara	cteristics	•	•	•	•	
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2.0	_	4.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 11.4 A	_	0.036	0.045	Ω
9FS	Forward Transconductance	V <sub>DS</sub> = 25 V, I <sub>D</sub> = 11.4 A	-	15	_	S
Dynamic (	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	-	725	945	pF
C <sub>oss</sub>	Output Capacitance		-	270	350	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		_	40	52	pF
Switching	Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 30 \text{ V}, I_D = 15 \text{ A},$	-	10	30	ns
t <sub>r</sub>	Turn-On Rise Time	$R_G = 25 \Omega$ (Note 4)	-	85	180	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		-	35	80	ns
t <sub>f</sub>	Turn-Off Fall Time		-	40	90	ns
Qg	Total Gate Charge	$V_{DS} = 48 \text{ V}, I_D = 30 \text{ A},$	-	19	25	nC
Qgs	Gate-Source Charge	V <sub>GS</sub> = 10 V (Note 4)	-	5.4	_	nC
Qgd	Gate-Drain Charge		-	8.5	-	nC
Drain-Sou	urce Diode Characteristics and Maximum	Ratings				
I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current		-	-	22.7	Α
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current		-	-	90.8	Α
$V_{SD}$	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 22.7 A	-	-	1.5	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 30 A, dI <sub>F</sub> /dt = 100 A/μs	-	45	-	ns
$Q_{rr}$	Reverse Recovery Charge		-	65	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 1. Repetitive Rating: Pulse–width limited by maximum junction temperature. 
  2. L = 630  $\mu$ H, I<sub>AS</sub> = 227 A, V<sub>DD</sub> = 25 V, R<sub>G</sub> = 25  $\Omega$  starting T<sub>J</sub> = 25°C. 
  3. I<sub>SD</sub>  $\leq$  30 A, di/dt  $\leq$  300 A/ $\mu$ s, V<sub>DD</sub>  $\leq$  BV<sub>DSS</sub>, starting T<sub>J</sub> = 25°C. 
  4. Essentially independent of operating temperature.

## **TYPICAL CHARACTERISTICS**

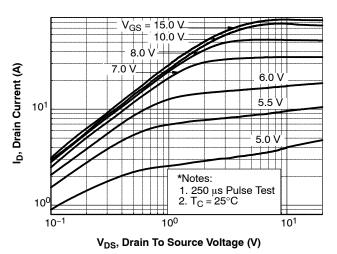


Figure 1. On-Region Characteristics

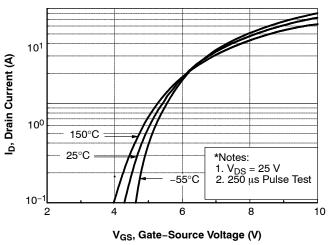


Figure 2. Transfer Characteristics

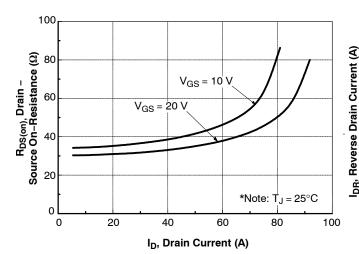


Figure 3. On–Resistance Variation vs
Drain Current and Gate Voltage

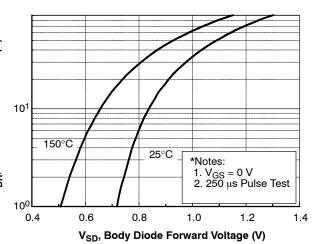


Figure 4. Body Diode Forward Voltage Variation vs Source Current and Temperature

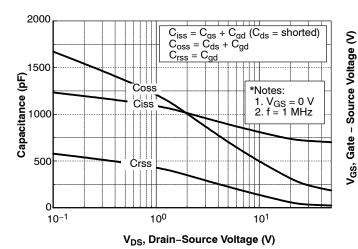


Figure 5. Capacitance Characteristics

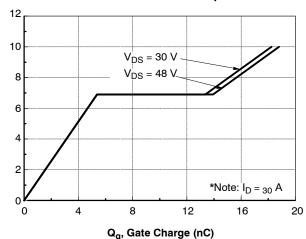


Figure 6. Gate Charge Characteristics

# TYPICAL CHARACTERISTICS (CONTINUED)

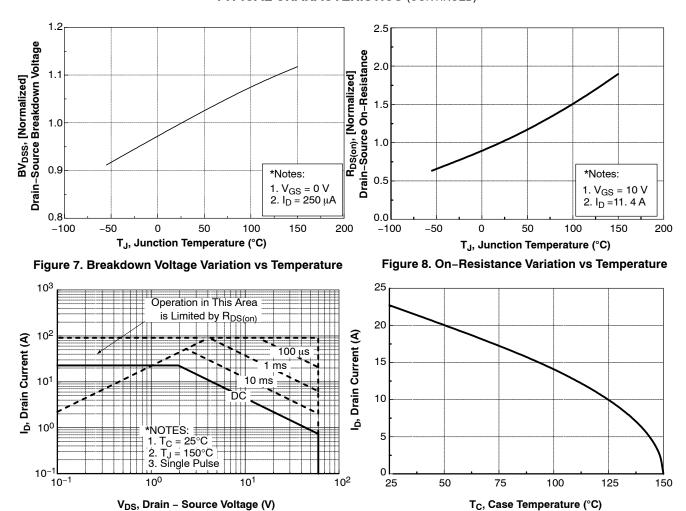


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

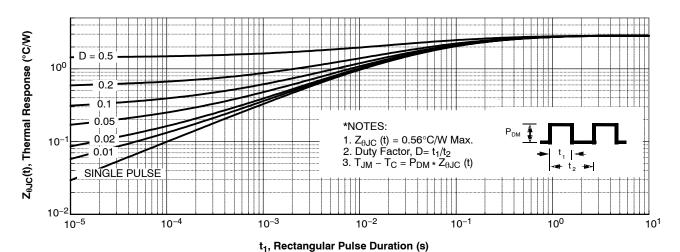


Figure 11. Transient Thermal Response Curve

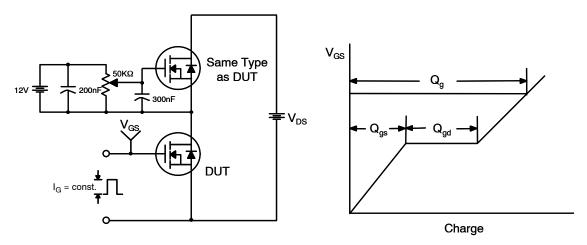


Figure 12. Gate Charge Test Circuit & Waveform

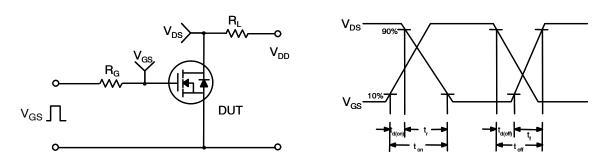


Figure 13. Resistive Switching Test Circuit & Waveforms

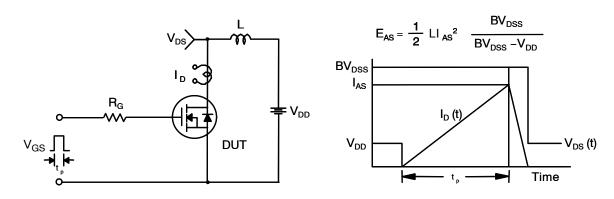
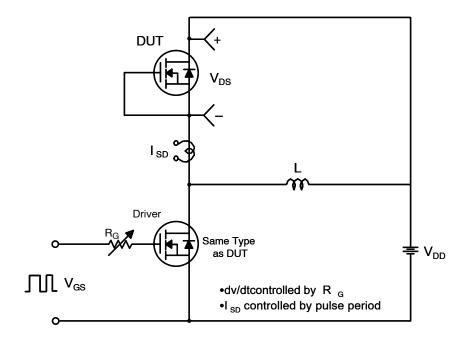


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



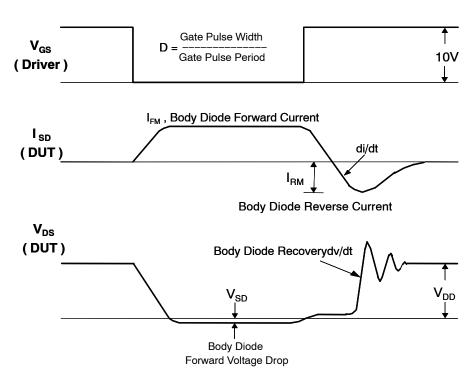


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms







## DPAK3 6.10x6.54x2.29, 4.57P CASE 369AS **ISSUE B**

**DATE 20 DEC 2023** 

- NOTES: UNLESS OTHERWISE SPECIFIED

  A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE F, VARIATION AA.

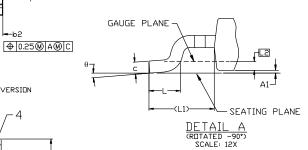
  B) ALL DIMENSIONS ARE IN MILLIMETERS.

  C) DIMENSIONING AND TOLERANCING PER

  - D)

A

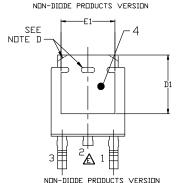
- F)
- DIMENSIONING AND TOLERANCING PER
  ASME Y14.5M-2018.
  SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED
  CORNERS OR EDGE PROTRUSION.
  FOR DIGDE PRODUCTS, L4 IS 0.25 MM MAX PLASTIC BODY
  STUB WITHOUT CENTER LEAD.
  DIMENSIONS ARE EXCLUSIVE OF BURRS,
  MOLD FLASH AND TIE BAR EXTRUSIONS.
  LAND PATTERN RECOMMENDATION IS BASED ON IPC7351A STD
  T0228P991X239-3N.

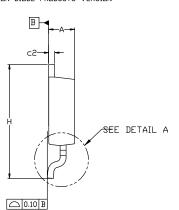


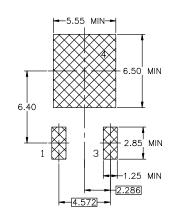
DIM	MILLIMETERS				
DIN	MIN.	N□M.	MAX.		
Α	2.18	2.29	2.39		
A1	0.00	-	0.127		
b	0.64	0.77	0.89		
b2	0.76	0.95	1.14		
b3	5.21	5.34	5.46		
C	0.45	0.53	0.61		
c2	0.45	0.52	0.58		
D	5.97	6.10	6.22		
D1	5.21				
E	6.35	6.54	6.73		
E1	4.32				
е	2.286 BSC				
e1	4.572 BSC				
Н	9.40	9,91	10.41		
L	1.40	1.59	1.78		
L1	2.90 REF				
L2	0.51 BSC				
L3	0.89	1.08	1.27		
L4			1.02		

θ

MILLIMETEDS







#### LAND PATTERN RECOMMENDATION

\*FOR ADDITIONAL INFORMATION ON DUR
PB-FREE STRATEGY AND SOLDERING DETAILS,
PLEASE DOWNLOAD THE ON SEMICONDUCTOR
SOLDERING AND MOUNTING TECHNIQUES
REFERENCE MANUAL, SOLDERRM/D.

# **GENERIC MARKING DIAGRAM\***

XXXXXX XXXXXX AYWWZZ

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

XXXX = Specific Device Code

= Assembly Location Α

= Year

WW = Work Week

ZZ = Assembly Lot Code

**DOCUMENT NUMBER:** 

98AON13810G

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**DESCRIPTION:** 

DPAK3 6.10x6.54x2.29, 4.57P

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